

Notice of References Cited	Application/Control No. 10/764,816	Applicant(s)/Patent Under Reexamination WU ET AL.	
	Examiner KAN YUEN	Art Unit 2616	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0021708 A1	02-2002	Ishiai, Katsuhiro	370/420
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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